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# Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









## AON6435

## 30V P-Channel MOSFET

## **General Description**

The AON6435 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $\mathsf{R}_{\mathsf{DS}(\mathsf{ON})}.$  This device is ideal for load switch and battery protection applications.

## **Product Summary**

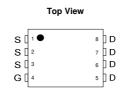
 $\rm V_{\rm DS}$ -30V  $I_D$  (at  $V_{GS} = -10V$ ) -34A  $R_{\text{DS}(\text{ON})}$  (at  $V_{\text{GS}}\text{=-}10\text{V})$  $<17\text{m}\Omega$  $R_{DS(ON)}$  (at  $V_{GS} = -5V$ )  $<34\text{m}\Omega$ 

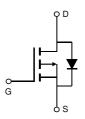
100% UIS Tested 100% R<sub>g</sub> Tested



Units







Parameter	Symbol	Maximum
Drain-Source Voltage	$V_{DS}$	-30
Gate-Source Voltage	$V_{GS}$	±25
Continuous Drain T <sub>C</sub> =25°C	l.	-34

Absolute Maximum Ratings T<sub>A</sub>=25℃ unless otherwise noted

		- j			
Drain-Source Voltage		V <sub>DS</sub>	-30	V	
Gate-Source Voltage		$V_{GS}$	±25	V	
Continuous Drain	T <sub>C</sub> =25℃		-34		
Current	T <sub>C</sub> =100℃	□ I <sub>D</sub>	-21.5	Α	
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	-95		
Continuous Drain	T <sub>A</sub> =25℃		-12	Δ	
Current	T <sub>A</sub> =70℃	IDSM	-10	Α Α	
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	24	Α	
Avalanche energy L=	:0.1mH <sup>C</sup>	E <sub>AS</sub>	29	mJ	
	T <sub>C</sub> =25℃	P <sub>D</sub>	31	W	
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100℃	- D	12.5	- vv	
	T <sub>A</sub> =25℃	D	4.1	W	
Power Dissipation <sup>A</sup>	T <sub>A</sub> =70℃	— P <sub>DSM</sub>	2.6	- vv	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	C	

Thermal Characteristics					
Parameter		Symbol	Тур	Max	Units
Maximum Junction-to-Ambient A	t ≤ 10s	D	24	30	°C/W
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	53	64	°C/W
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	3.4	4	℃/W



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC PARAMETERS							
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-30			V	
I <sub>DSS</sub> Zero Gate Voltage Drain Currer	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V			-1	μА	
		T <sub>J</sub> =55℃			-5	po. 1	
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±25V			±100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS,}I_{D}=-250\mu A$	-1.7	-2.3	-3	V	
$I_{D(ON)}$	On state drain current	$V_{GS}$ =-10V, $V_{DS}$ =-5V	-95			Α	
		V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A		13	17	mΩ	
$R_{DS(ON)}$	R <sub>DS(ON)</sub> Static Drain-Source On-Resistance	T <sub>J</sub> =125℃		19	25		
		$V_{GS}$ =-5V, $I_D$ =-15A		25	34	mΩ	
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =-5V, $I_{D}$ =-20A		28		S	
$V_{SD}$	Diode Forward Voltage	$I_S=-1A, V_{GS}=0V$		-0.73	-1	V	
$I_S$	Maximum Body-Diode Continuous Curr	ent			-35	Α	
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance			1130	1400	pF	
Coss	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =-15V, f=1MHz		240		pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			155		рF	
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		5.8	8	Ω	
SWITCHII	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge			21		nC	
Q <sub>g</sub> (4.5V)	Total Gate Charge	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-20A		10		nC	
$Q_{gs}$	Gate Source Charge			4		nC	
$Q_{gd}$	Gate Drain Charge			6		nC	
t <sub>D(on)</sub>	Turn-On DelayTime			10		ns	
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =-10V, $V_{DS}$ =-15V,		8		ns	
$t_{D(off)}$	Turn-Off DelayTime	$R_L=0.75\Omega$ , $R_{GEN}=3\Omega$		15		ns	
t <sub>f</sub>	Turn-Off Fall Time	]		7		ns	
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =-20A, dI/dt=500A/μs		13.5		ns	
$Q_{rr}$	Body Diode Reverse Recovery Charge	I <sub>F</sub> =-20A, dI/dt=500A/μs		29		nC	

A. The value of  $R_{0JA}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^{\circ}$  C. The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$  and the maximum allowed junction temperature of  $150^{\circ}$  C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub> =25° C.Maximum UIS current limited by test equipment.

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

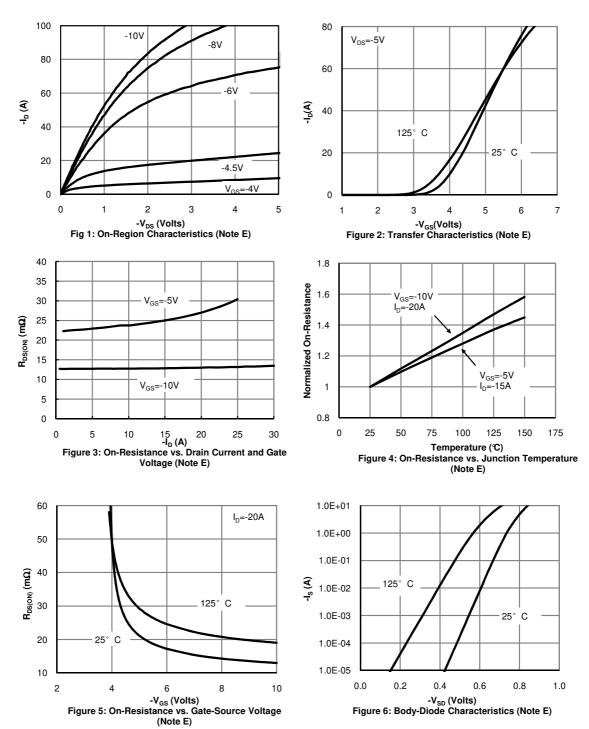
E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

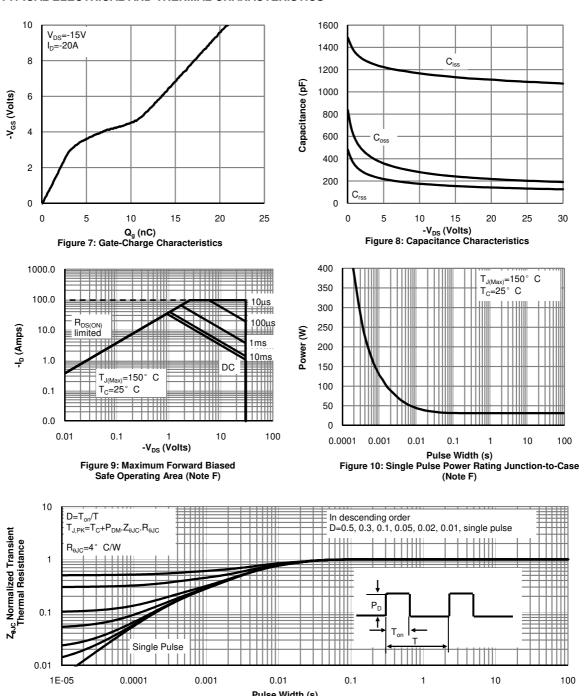
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.



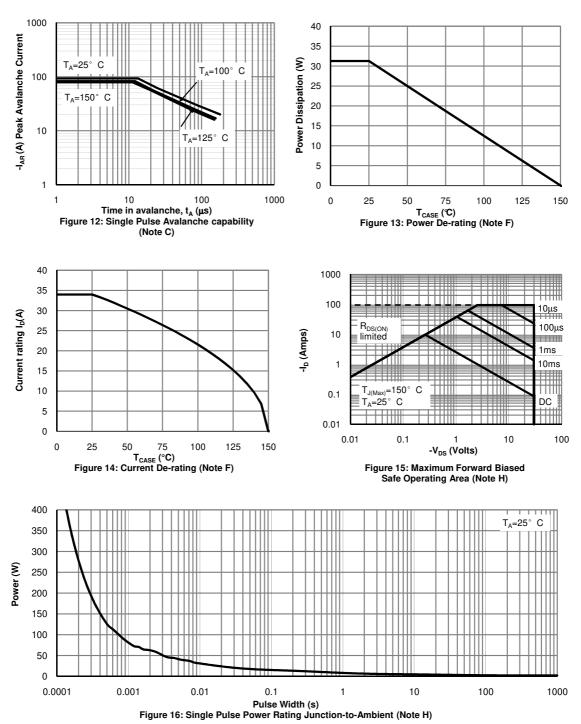




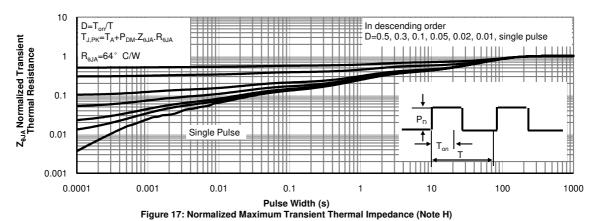


Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



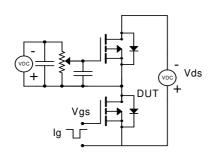


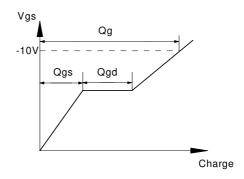




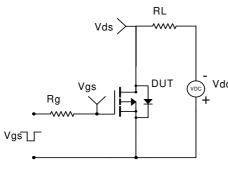


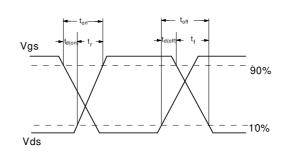
## Gate Charge Test Circuit & Waveform



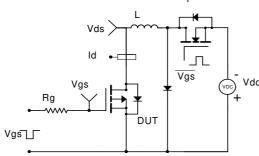


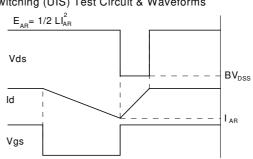
## Resistive Switching Test Circuit & Waveforms





## Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





## Diode Recovery Test Circuit & Waveforms

